

**Search Notes**

Application/Control No.

10/799,596

Examiner

Emily Y. Chan

Applicant(s)/Patent under  
Reexamination

YANO ET AL.

Art Unit

2829

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventorship and Plus searched	8/16/2005	EC
324/767,770 and G09G/3/32 IPC (text searched -only see search history priontout)	8/16/2005	EC